



Product Change Notice

Micron PCN: 31234
 Date: 5/23/2014

Type of Change:	Internal Device Algorithm Change	
Title of Change:	Serial NOR N25Q128A13E updated with improved Erase/Program performance	
Description of Change:	N25Q128A13E 3V Serial NOR will be shipped with new improved Erase/Program performance. Typ tSE = 0.3 sec / Max tSE = 1 sec Typ tSSE = 0.06 ms / Max tSSE = 0.2 sec Typ tPP = 0.2 ms / Max tPP = 0.4 ms Typ tBE = 46 sec / Max tBE = 250 sec	
Reason for Change:	Better Align Industry Standards	
Contact Information:	<u>Marketing Contact</u> SALVATORE MASSIMO Micron Semiconductor Ital SFAVA@MICRON.COM	<u>Engineering Contact</u> FRANCESCO LUPO Micron Semiconductor Ital LUPOF@MICRON.COM

Product Affected: N25Q128A13E 3V Serial NOR

Affected Micron Part Number

N25Q128A13E1240E	N25Q128A13ESE40F
N25Q128A13E1240F	N25Q128A13ESE40G
N25Q128A13E1241E	N25Q128A13ESEC0E
N25Q128A13E1241F	N25Q128A13ESEC0F
N25Q128A13E1440E	N25Q128A13ESEC0G
N25Q128A13E1440F	N25Q128A13ESF40E
N25Q128A13E1441E	N25Q128A13ESF40F
N25Q128A13E1441F	N25Q128A13ESF40G
N25Q128A13EF740E	N25Q128A13ESF4FF
N25Q128A13EF740F	N25Q128A13ESF4FG
N25Q128A13EF840E	N25Q128A13ESFC0F
N25Q128A13EF840F	N25Q128A13ESFC0G
N25Q128A13EF8C0E	N25Q128A13EV740
N25Q128A13EF8C0F	N25Q128A13EV741
N25Q128A13ESE40E	

Method of Identification: Devices from week code 36 2014 will have the new performances.

Micron Sites Affected:	Subcontractor
Sample Available:	Now
Qual Data Available:	Now
Product Ship Date:	1-Sep-2014

Note: Per JEDEC Standard JESD46-C Section 3.2.3; lack of acknowledgment of this PCN within 30 days constitutes acceptance of change